IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Accompanying Continuation Application Under
37 CFR 1.53(b):

Prior Application:	M. IWAYAMA et al
	Serial No. 09/442,147
	Filed: November 18, 1999
Group Art:	2171
Examiner:	C. Rones
For:	A METHOD OF SEARCHING DOCUMENTS AND
	A SERVICE FOR SEARCHING DOCUMENTS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
Washington, D.C.   20231   February 15, 2002

Sir:

In accordance with the duty of disclosure, the Applicants

inform the Examiner of the documents cited during prosecution

of the parent application, USSN 09/442,147.

The Applicants request the Examiner to initial and return

a copy of the attached PTO-1449 form as an indication that the

references have been considered.

Respectfully submitted,

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Alexandria, Virginia 22314
(703) 684-1120
Date: February 15, 2002

FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. NIT-163-02	SERIAL NO.
LIST OF DOCUMENTS CITED BY APPLICANT *(Use several sheets if necessary)*		APPLICANT M. IWAYAMA et al	
		FILING DATE February 15, 2002	GROUP

U.S. PATENT DOCUMENTS

* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE *(If Appropriate*
	AA	5,590,319	12/31/96	Cohen et al			
	AB	5,987,460	11/1999	Niwa et al			
	AC	5,926,811	07/1999	Miller et al			
	AD	5,870,740	02/1999	Miller et al			
	AE						
	AF						
	AG						
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	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO
	AL	64-74210	03/20/89	Japan			☐	☐
	AM	93/37499	08/27/98	WO PCT			☐	☐
	AN	10-74210	03/17/98	Japanese Laid-Open Patent			☐	☐
	AO	11-85786	03/30/99	Japanese Laid-Open Patent			☐	☐
	AP	10-254887	09/25/98	Japanese Laid-Open Patent			☐	☐

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, etc.)*

	AR	B. Velez et al, "Fast and Effective Query Refinement", Annual International ACM-SIGIR Conference on Research and Development in Information Retrieval, US, New York, NY, July 27, 1997, pp. 6-15.
	AS	
	AT	

EXAMINER	DATE CONSIDERED

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form next communication to applicant.

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		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIO YES	NO
	AL	8-287103	11/01/96	Japanese Laid-Open Patent			☐	☐
	AM	9-62693	03/07/97	Japanese Laid-Open Patent			☐	☐
	AN						☐	☐
	AO						☐	☐
	AP						☐	☐

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